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(54) SOLAR CELL AND SOLAR CELL MODULE

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H01L 31/0224 (2006.01)

H01L 31/18 (2006.01)

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CPC ... H01L 31/00; H01L 31/02; H01L 31/02008; H01L 31/0201; H01L 31/0224;

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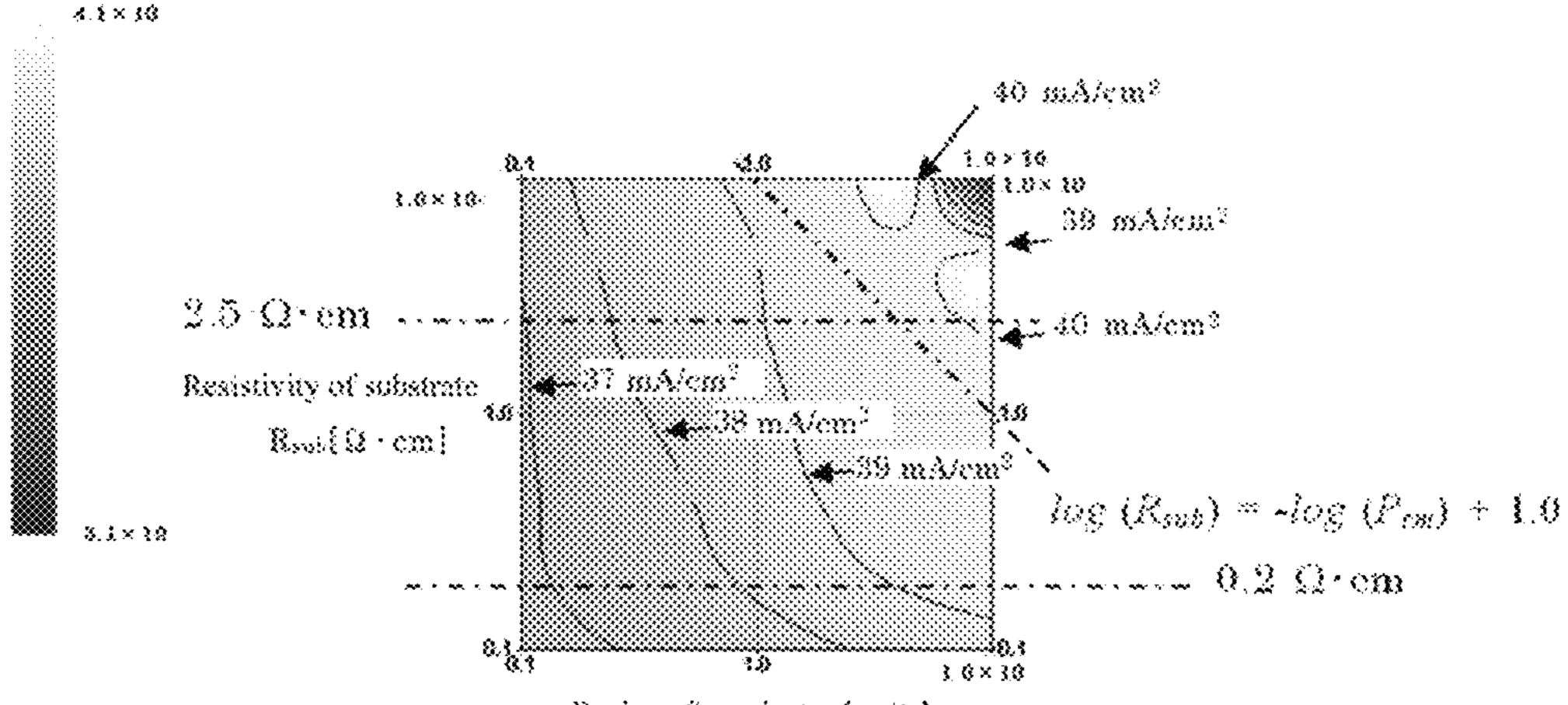
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(57) ABSTRACT

A method for manufacturing a solar cell having a P-type silicon substrate wherein one main surface is a light-receiving surface and another is a backside, a plurality of back surface electrodes formed on a part of the backside, an N-type layer in at least a part of the light-receiving surface, and contact areas in which the substrate contacts the electrodes; wherein the P-type silicon substrate is a silicon substrate doped with gallium and has a resistivity of 2.5 Ω ·cm or less; and a back surface electrode pitch P_{rm} [mm] of contact areas in which the P-type silicon substrate is in contact with the back surface electrodes and the resistivity R_{sub} [Ω ·cm] of the substrate satisfy the relation represented by the following formula (1).

$$\log(R_{sub}) \le -\log(P_{rm}) + 1.0 \tag{1}$$

22 Claims, 4 Drawing Sheets



Back sarisce electrode pitch

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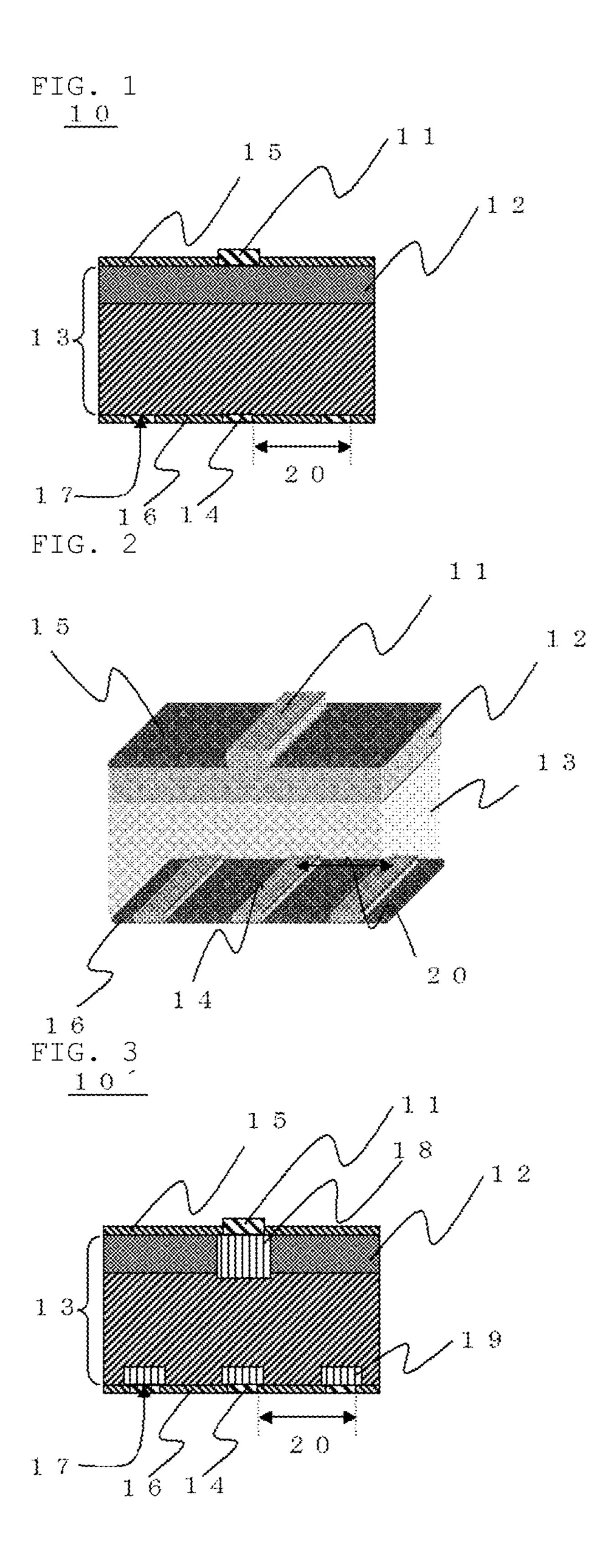
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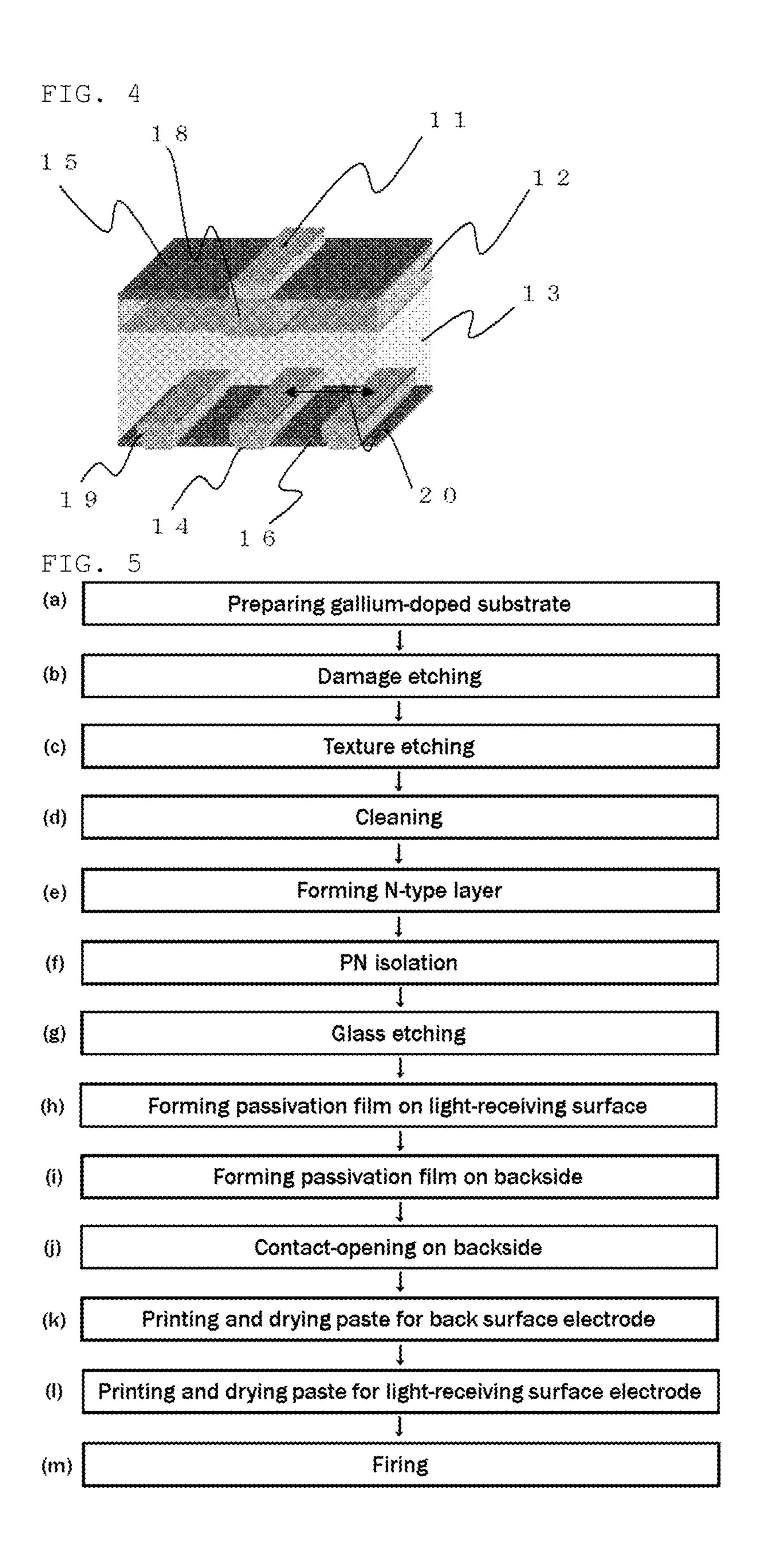


FIG. 6

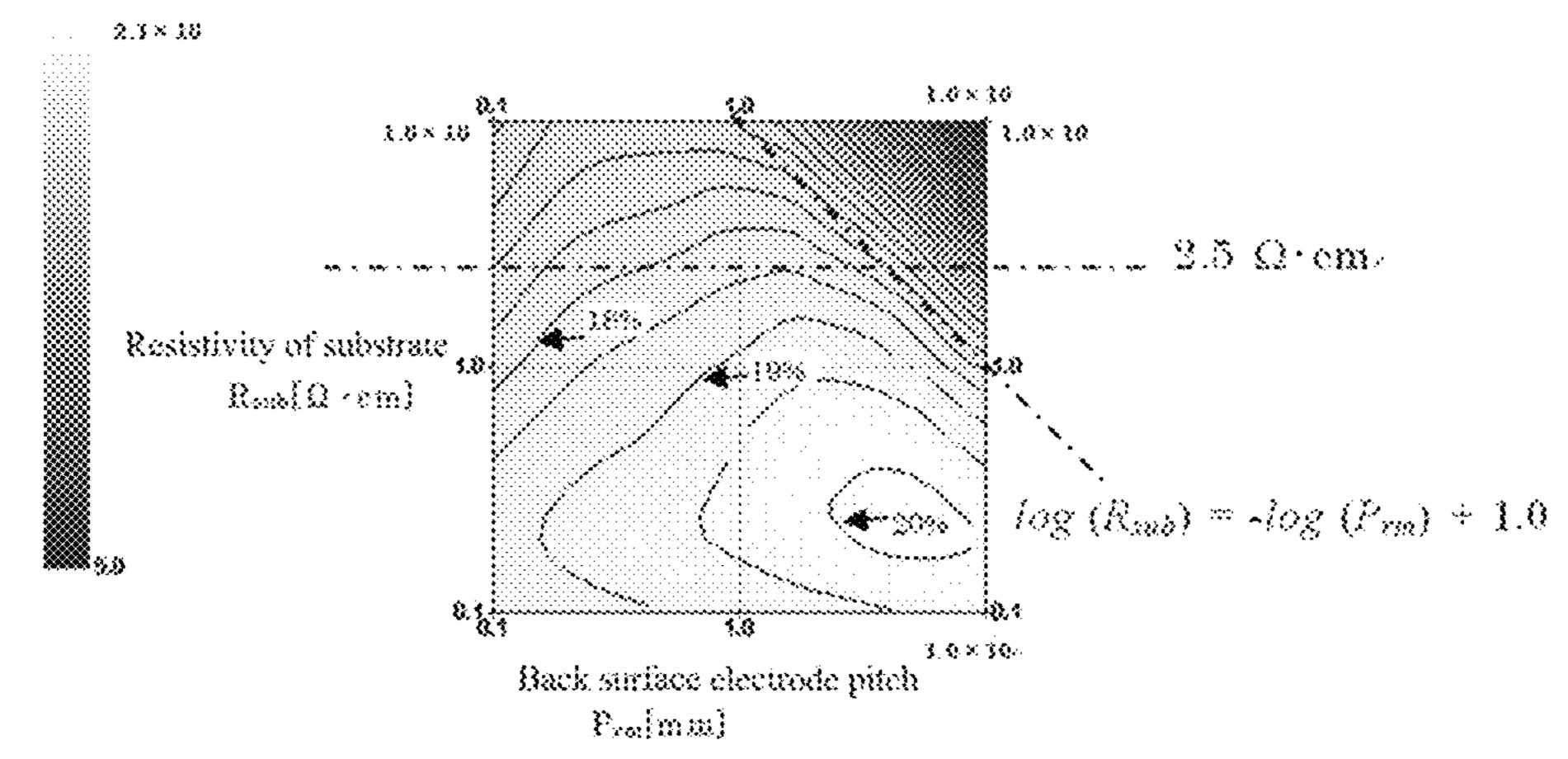
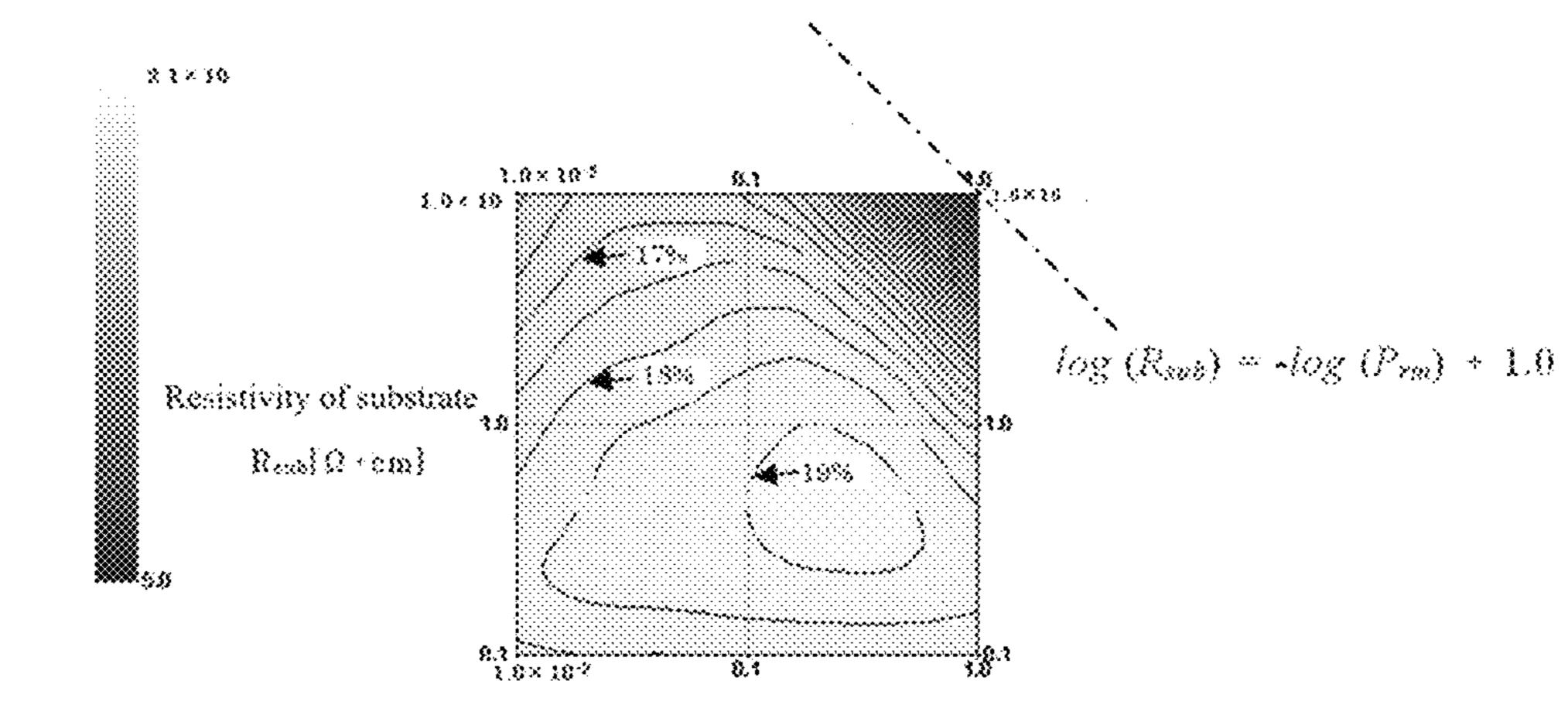
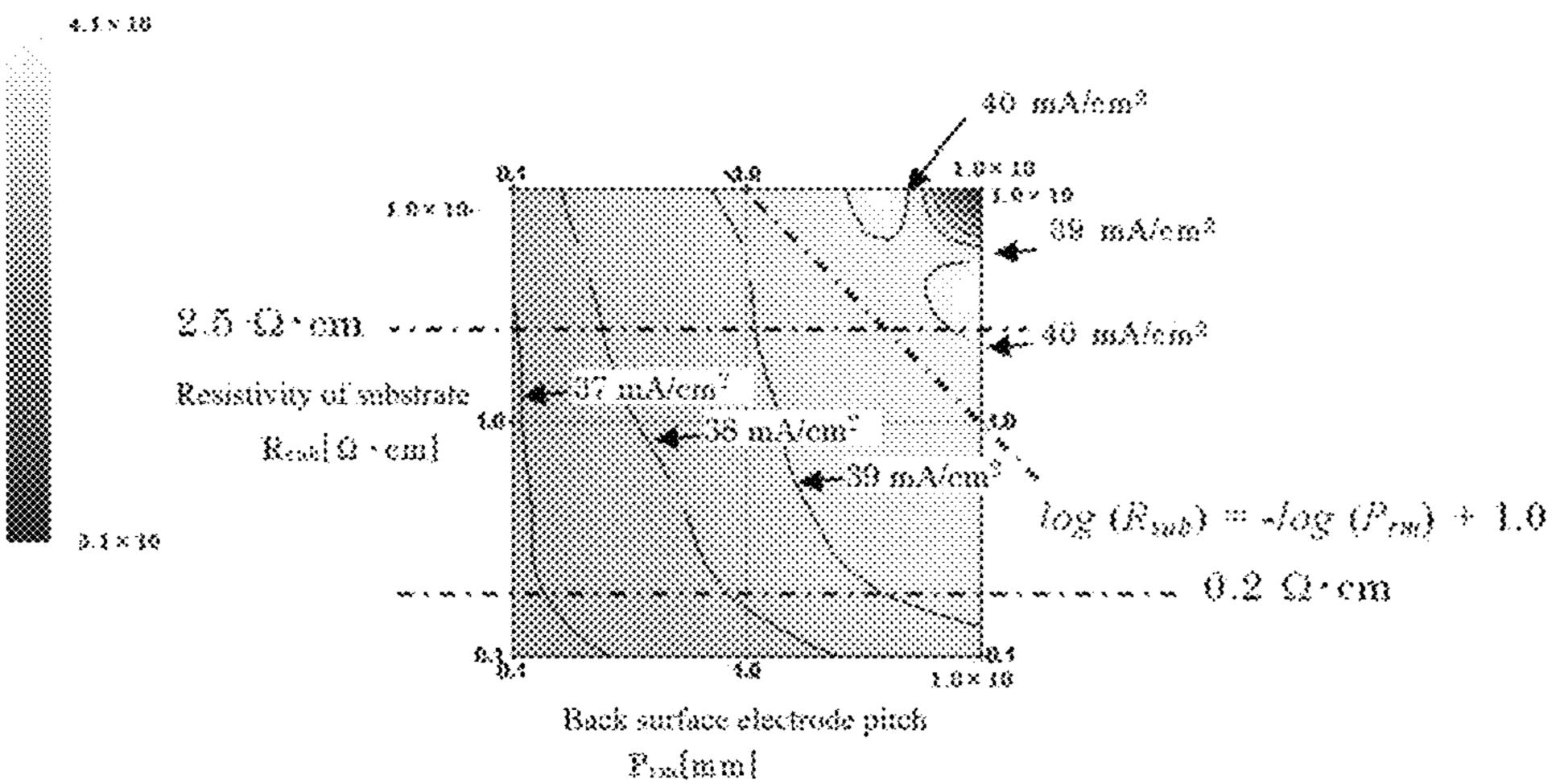


FIG. 7

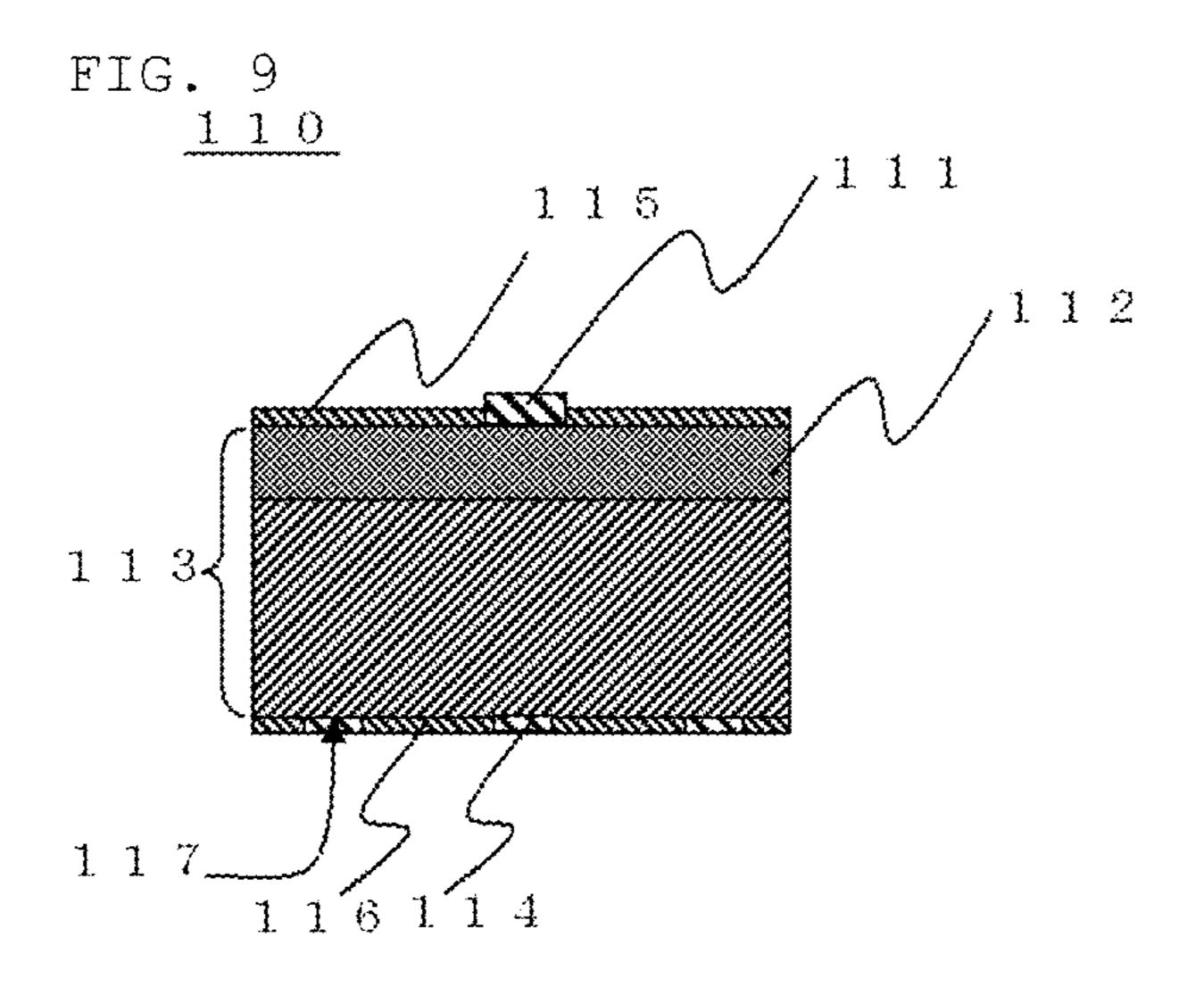


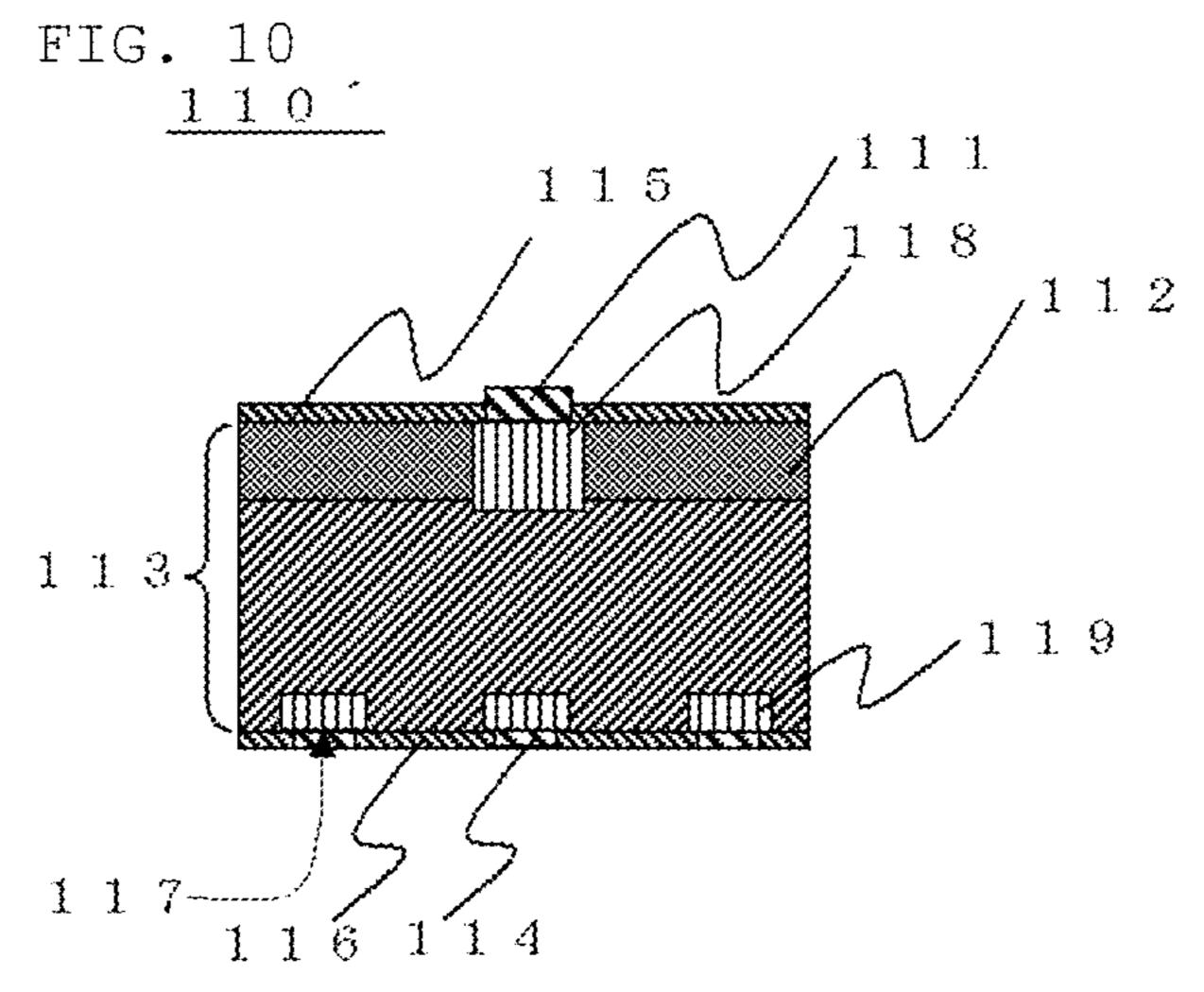
Back surface electrode pitch $P_{res}\{mm\}$

FIG. 8



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SOLAR CELL AND SOLAR CELL MODULE

This is a Continuation of application Ser. No. 15/523,923 filed May 2, 2017, which in turn is a national stage of PCT/JP2015/005190 filed Oct. 14, 2015, which claims priority to JP 2014-230517 filed Nov. 13, 2014. The disclosure of the prior applications is hereby incorporated by reference herein in its entirety.

TECHNICAL FIELD

The present invention relates to a solar cell and a solar cell module.

BACKGROUND ART

Semiconductor substrates for solar cells are usually manufactured by a Czochralski method (CZ method), which can produce a single crystal with a large-diameter at relatively low cost. For example, P-type semiconductor substrates can be obtained by drawing a silicon single crystal doped with boron by a CZ method, and slicing this single crystal.

Single crystal silicon solar cells (solar cells made of single crystal silicon substrates) have been configured to have a structure in which the whole surface of the backside (the surface opposite to the light-receiving surface) is in contact with the electrode via a Back Surface Field (BSF) structure.

The BSF structure can be easily introduced by a screen printing method, and is widely spread to be the mainstream of structures of present silicon single crystal solar cells.

Contact Solar Cell (PERC) structure and a Passivated Emitter and Rear Locally Diffused Solar Cell (PERL) structure come to be introduced in order to further improve the efficiency.

The PERC structure and the PERL structure are methods to aggressively reduce the recombination rate of minority carriers on the back surface, that is, methods to reduce an effective surface recombination velocity on the back surface.

The cross section of a previous solar cell having a PERC 45 structure is schematically shown in FIG. 9. As shown in FIG. 9, the solar cell 110 is provided with the N-type layer 112 on the side of the light-receiving surface of the silicon substrate 113 doped with boron (hereinafter, also described as a boron-doped substrate), and the finger electrodes 111 on this N-type layer 112. In many cases, the solar cells have the passivation layer 115 on the light-receiving surface. The solar cell is also provided with the passivation layer 116 on the back surface, the electrodes 114 on the back surface, and the contact areas 117 where the boron-doped substrate 113 is locally in contact with the back surface electrodes 114.

The cross section of a previous solar cell having a PERL structure is schematically shown in FIG. 10. As shown in provided with the P⁺ layer (i.e., the layer which is doped with P-type dopant in higher concentration than the surrounding area (P-type silicon substrate)) 119 immediately under the back surface electrodes 114. This may be provided with N⁺ layer (i.e., the layer which is doped with N-type 65 dopant in higher concentration than the surrounding N-type layer 112) 118 under the light-receiving surface electrode

111. Other structures are similar to the solar cell having a PERC structure in FIG. 9, and the explanation is omitted.

CITATION LIST

Patent Literature

Patent Literature 1: pamphlet of International Patent Laid-Open Publication No. WO 2000/073542

SUMMARY OF INVENTION

Technical Problem

Even though a solar cell has the PERC structure or the PERL structure to reduce the recombination rate of minority carriers on the back surface, when the substrate is a borondoped substrate, the interstitial boron atom combines with interstitial oxygen atoms by irradiated light to form a recombination site in the substrate bulk, which reduces the lifetime of the minority carriers to degrade the characteristics of the solar cell. This phenomenon is also referred to as light-induced degradation of a solar cell using a borondoped substrate.

In solar cells having the PERC structure and the PERL structure, the electrode on the back surface is localized. This generates current crowding in the vicinity of the contact (i.e., the contact area where the substrate is in contact with the back surface electrode), and tends to cause resistance loss. Accordingly, a substrate with low resistance is preferable in the solar cell having the PERC structure or the PERL structure. However, when using a substrate with low resistance, that is, in a situation in which more boron atoms are contained, the combination of a boron atom and oxygen To the BSF structure, a Passivated Emitter and Rear 35 atoms increases to make the degradation (light-induced degradation) noticeable thereby.

> On the other hand, using a substrate with higher resistance reduces the degradation. In a solar cell having the PERC structure or the PERL structure, however, current crowding significantly generates in the vicinity of the contact on the back surface to cause resistance loss as described above. As a result, the characteristics degrade also in this case.

> To eliminate the light-induced degradation, Patent Literature 1 suggests the use of gallium as P-type dopant instead of boron. It has been impossible to sufficiently prevent the resistance loss, however, only by using a silicon substrate doped with gallium (hereinafter, also referred to as a gallium-doped substrate) as the substrate of the solar cell having the PERC structure or the PERL structure.

> The present invention was accomplished in view of the above-described problems. It is an object of the present invention to provide a solar cell and a solar cell module having excellent conversion efficiency with the resistance loss being prevented, with the solar cell using a substrate the light-induced degradation of which is eliminated.

Solution to Problem

To achieve the above-described object, the present inven-FIG. 10, the solar cell 110' is the solar cell 110 that is 60 tion provides a solar cell comprising a P-type silicon substrate in which one main surface is a light-receiving surface and another main surface is a backside, a plurality of back surface electrodes formed on a part of the backside, an N-type layer in at least a part of the light-receiving surface of the P-type silicon substrate, and contact areas in which the P-type silicon substrate is in contact with the back surface electrodes;

wherein the P-type silicon substrate is a silicon substrate doped with gallium;

the P-type silicon substrate has a resistivity of 2.5 Ω ·cm or less; and

a back surface electrode pitch P_{rm} [mm] of the plurality of 5 back surface electrodes and the resistivity R_{sub} [Ω ·cm] of the P-type silicon substrate satisfy the relation represented by the following formula (1)

$$\log(R_{sub}) \le -\log(P_{rm}) + 1.0 \tag{1}.$$

In such a solar cell, since the substrate is a gallium-doped substrate, the light-induced degradation is eliminated. The substrate is also a substrate with lower resistance, which hardly generates current crowding in the contact area to scarcely cause resistance loss. The solar cell has the PERC structure with a lower resistance substrate, and can sufficiently reduce the recombination rate of the minority carriers on the back surface side. In addition to these structures, the pitch of the electrodes on the back surface (hereinafter, also referred to as a back surface electrode pitch) and the resistivity of the substrate satisfy the relation represented by the foregoing formula (1), which makes it possible to minimize the resistance loss due to the current crowding and to further increase the output power.

FIG. 3 inventive

FIG. 4

FIG. 5 manufactor

FIG. 6

of the solar cell has the PERC substrate;

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FIG. 6 of the solar cell has the PERC substrate;

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FIG. 7 of the solar cell has the PERC substrate;

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FIG. 9 of the solar cell has the PERC substrate;

FIG. 9 of the solar cell has the PERC subs

It is preferable that the resistivity of the P-type silicon 25 substrate be $0.2~\Omega\cdot\text{cm}$ or more.

Such solar cells can generate current in virtually the same level even when the solar cell module is composed of solar cells with different resistivity. Accordingly, excess loss can be reduced when the solar cell module is fabricated using 30 such solar cells.

It is also preferable that the pitch of back surface electrodes be 10 mm or less.

Such a solar cell can be definitely a solar cell with excellent conversion efficiency.

It is also preferable that each of the contact areas have a higher P-type dopant concentration than other area.

Such a solar cell with a PERL structure having a so-called P⁺ layer is excellent in conversion efficiency.

It is also preferable that the total area of the contact areas 40 be 20% or less of the total backside area.

Such a solar cell makes it possible to further reduce the carrier recombination on the contact between the substrate and the electrode while making the contact resistance lower between the substrate and the electrode.

The present invention also provides a solar cell module comprising the inventive solar cell.

In the inventive solar cell, the light-induced degradation and the resistance loss are eliminated, while the conversion efficiency is excellent. Accordingly, in the solar cell module 50 provided with the inventive solar cell, the light-induced degradation and the resistance loss are eliminated, while the conversion efficiency is excellent.

Advantageous Effects of Invention

In the inventive solar cell, since the substrate is a gallium-doped substrate, the light-induced degradation is eliminated. The substrate is also a substrate with lower resistance, which hardly generates current crowding near the contact area to 60 scarcely cause resistance loss. The solar cell has the PERC structure or the PERL structure with a lower resistance substrate, and can sufficiently reduce the recombination rate of the minority carriers on the back surface side. In addition to these structures, the electrode pitch on the back surface 65 and the resistivity of the substrate satisfy the relation represented by the foregoing formula (1), which makes it

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possible to minimize the resistance loss due to the current crowding and to further increase the output power.

BRIEF DESCRIPTION OF DRAWINGS

FIG. 1 is a sectional view showing an example of the inventive solar cell;

FIG. 2 is a schematic drawing of the solar cell shown in FIG. 1 on a perspective projection of the P-type silicon substrate:

FIG. 3 is a sectional view showing an example of the inventive solar cell;

FIG. 4 is a schematic drawing of the solar cell shown in FIG. 3 on a perspective projection of the P-type silicon substrate;

FIG. 5 is a flow diagram of an example of a method for manufacturing the inventive solar cell;

FIG. 6 is a diagram of the average conversion efficiency of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the gallium-doped substrate after sufficient irradiation of the sunlight;

FIG. 7 is a diagram of the average conversion efficiency of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the boron-doped substrate after sufficient irradiation of the sunlight;

FIG. 8 is a diagram of the average short-circuit current density of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the gallium-doped substrate;

FIG. 9 is a sectional view schematically showing a previous solar cell having a PERC structure; and

FIG. 10 is a sectional view schematically showing a previous solar cell having a PERL structure.

DESCRIPTION OF EMBODIMENTS

Hereinafter, the present invention will be more specifically described.

As described above, an excellent conversion efficiency solar cell with eliminating the resistance loss has been demanded for solar cells using a substrate which eliminates the light-induced degradation. As a structure that can enhance the conversion efficiency, the PERC structure and the PERL structure have been proposed. However, only by using a gallium-doped substrate which can eliminate light-induced degradation for a solar cell having the PERC structure or the PERL structure, it has been impossible to sufficiently prevent resistance loss to provide the solar cell with excellent conversion efficiency.

The inventor has diligently investigated to solve the problems. As a result, the inventor has found that the foregoing problem can be solved with the solar cell having a PERC structure or a PERL structure provided with a gallium-doped substrate having a lower resistance, with the back surface electrode pitch and the resistivity substrate satisfying a specific relation; thereby brought the inventive solar cell and the solar cell module to completion.

Hereinafter, an embodiment of the present invention will be specifically described with reference to FIGS, but the present invention is not limited thereto. [Solar Cell]

FIG. 1 is a sectional view showing an example of the inventive solar cell. FIG. 2 is a schematic drawing of the solar cell shown in FIG. 1 on a perspective projection of the P-type silicon substrate 13. As shown in FIG. 1 and FIG. 2, the inventive solar cell 10 is provided with the P-type silicon substrate (gallium-doped substrate) 13 in which one of the

main surface is a light-receiving surface and another main surface is a backside. This also has a plurality of back surface electrodes 14 formed on a part of the backside of the P-type silicon substrate 13. The P-type silicon substrate 13 has an N-type layer 12 in at least a part of the light-receiving surface, and also has the contact areas 17 where the P-type silicon substrate 13 is in contact with the back surface electrodes 14. The N-type layer 12 is generally provided with the light-receiving surface electrode 11 thereon.

In the present invention, the P-type silicon substrate 13 is a gallium-doped substrate. By changing the P-type dopant from boron to gallium like this, the light-induced degradation can be eliminated. The P-type silicon substrate 13 has a resistivity (specific resistance) of 2.5 Ω ·cm or less. The resistivity more than 2.5 Ω ·cm can cause current crowding 15 in the vicinity of portions on the back surface side where the P-type silicon substrate 13 is in contact with the back surface electrodes 14, which can cause resistance loss.

As described above, the inventive solar cell is provided with a gallium-doped substrate having lower resistance (i.e., 20 a substrate with high gallium concentration). The solar cell having a PERC structure or a PERL structure is particularly excellent in conversion efficiency when having a substrate with lower resistance. Accordingly, the inventive solar cell is particularly excellent in conversion efficiency. The inventive solar cell, having a gallium-doped substrate with lower resistance, hardly yield light-induced degradation, which occurs in a boron-doped substrate with lower resistance (i.e., a substrate with high boron concentration), and can keep the high efficiency.

In the inventive solar cell 10, the back surface electrode pitch P_{rm} [mm] of the plurality of back surface electrodes 14 and the resistivity R_{sub} [$\Omega \cdot \text{cm}$] of the P-type silicon substrate 13 satisfy the relation represented by the following formula (1)

$$\log(R_{sub}) \le -\log(P_{rm}) + 1.0 \tag{1}$$

The back surface electrode pitch **20** is shown in FIG. **1**. When the back surface electrode pitch **20** and the resistivity of the gallium-doped substrate **13** do not satisfy the relation 40 represented by the formula (1), it is not possible to sufficiently prevent resistance loss due to current crowding, causing the decrease in the output power. The relation of the formula (1) was obtained by the following computer simulation.

In the solar cell shown in FIG. 1, the conversion efficiency of the solar cell was simulated by using a computer, as a function of the electrode pitch on the back surface and the resistivity of the gallium-doped substrate. The results are shown in FIG. 6.

In the solar cell shown in FIG. 9, the conversion efficiency of the solar cell was also simulated by using a computer, as a function of the electrode pitch on the back surface and the resistivity of the boron-doped substrate. The results are shown in FIG. 7. In FIG. 6 and FIG. 7, the conversion 55 efficiency is shown by the light and shade. It is also shown by contour lines of conversion efficiency, each of which links each point of combination of the resistivity of the substrate and the back surface electrode pitch.

FIG. 6 is a diagram showing the average conversion 60 efficiency of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the gallium-doped substrate after sufficient irradiation of the sunlight. As shown in FIG. 6, when the resistivity of the gallium-doped substrate was $2.5 \ \Omega \cdot \text{cm}$ or less, and the back 65 surface electrode pitch and the substrate resistivity of a gallium-doped substrate satisfied the relation represented by

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the foregoing formula (1), the results of conversion efficiency were excellent. On the other hand, as shown in FIG. 6, the conversion efficiency suddenly dropped when the resistivity was more than $2.5 \ \Omega \cdot \text{cm}$ or when the formula (1) was not satisfied.

FIG. 7 is a diagram of the average conversion efficiency of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the boron-doped substrate after sufficient irradiation of the sunlight. As shown in FIG. 7, when a boron-doped substrate was used, the conversion efficiency was inferior to the case of using a gallium-doped substrate. This shows an influence of light-induced degradation. In this instance, the conversion efficiency suddenly dropped in some cases even when the back surface electrode pitch and the substrate resistivity of a boron-doped substrate satisfied the relation represented by the formula (1).

In the solar cell shown in FIG. 1, the short-circuit current density of the solar cell was simulated, as a function of the electrode pitch on the back surface and the resistivity of the gallium-doped substrate. The results are shown in FIG. 8. FIG. 8 is a diagram showing the average short-circuit current density of the solar cell as a function of the electrode pitch on the back surface and the substrate resistivity of the gallium-doped substrate. In FIG. 8, the short-circuit current density are shown by the light and shade. They are also shown as contour lines of the short-circuit current density, each of which links each point of combination of the resistivity of the substrate and the back surface electrode pitch. As shown in FIG. 8, when the resistivity of a galliumdoped substrate was 2.5 Ω ·cm or less, and the back surface electrode pitch and the resistivity of the gallium-doped substrate satisfied the relation represented by the formula (1), the short-circuit current density showed smaller varia-35 tion than the substrate resistivity.

When the resistivity of a gallium-doped substrate was 0.2 Ω ·cm or more, the short-circuit current density showed much smaller variation than the substrate resistivity. These results reveal that the solar cell which has a resistivity of 0.2 Ω ·cm or more and 2.5 Ω ·cm or less and satisfies the relation represented by the formula (1) shows similar current even when the solar cells have resistivity variation. Accordingly, it turned out that these solar cells can reduce excess loss when they are modularized. As described above, it is preferable that the resistivity of the P-type silicon substrate (gallium-doped substrate) 13 be 0.2 Ω ·cm or more.

The thickness of the P-type silicon substrate 13 is not particularly limited, and can be a thickness of 100 to 200 µm, for example. The shape and area of the main surface of the P-type silicon substrate 13 is not particularly limited.

It is also preferable that the back surface electrode pitch **20** of the plurality of back surface electrodes be 10 mm or less. Such a solar cell is excellent in conversion efficiency as shown in FIG. **6**. The lower limit of the back surface electrode pitch **20** is not particularly limited, and can be 1 mm, for example.

It is also preferable that each P-type dopant concentration in the contact areas 17 be higher than the P-type dopant concentration in an area other than the contact areas 17. As an example of such a solar cell having a PERL structure, the solar cell shown in FIG. 3 and FIG. 4 can be enumerated. FIG. 3 is a sectional view showing an example of the inventive solar cell. FIG. 4 is a schematic drawing of the solar cell shown in FIG. 3 on a perspective projection of the P-type silicon substrate 13. In the solar cell shown in FIG. 3 and FIG. 4, the same reference number is given to each of the same components as those in the solar cell shown in FIG.

1, and the explanation is omitted. As shown in FIG. 3 and FIG. 4, the solar cell 10' is the one in which the foregoing solar cell 10 is provided with N⁺ layer 18 immediately under the light-receiving surface electrode 11, and the P⁺ layer 19 immediately under the back surface electrodes 14 (in the 5 vicinity of the contact areas 17). Such a solar cell having a PERL structure can be a solar cell that is excellent in conversion efficiency.

It is also preferable that the total area of the contact areas 17 be 20% or less on the basis of the whole of the backside. 10 In such a solar cell, it is possible to further reduce the recombination of carriers due to the contact between the substrate and the electrode while making the contact resistance much lower between the substrate and the electrode. The lower limit of the total area of the contact areas 17 is not 15 point prove method, for example. particularly limited, and can be 5%, for example. The electrode widths of the light-receiving surface electrode 11 and the back surface electrodes 14 are not particularly limited, and can be 15 to 100 µm, for example.

generally provided with the surface passivation layer 16 on the back surface. It is also possible to have the surface passivation layer 15 on the light-receiving surface. The passivation layer 15 on the light-receiving surface can also act as an anti-reflection film, etc. As these passivation layers, 25 it is possible to use a silicon nitride layer (SiNx layer) and SiO₂ layer, which can be fabricated by using a plasma CVD, and to use a thermal oxide layer too. The effect on antireflection shows maximum value when the layer thickness of the anti-reflection film is 85 to 105 nm, which is favor- 30 able.

It is also possible to have metal such as aluminum on the whole surface of the back surface passivation layer 16 to form a structure in which the plurality of back surface in which the back surface electrodes 14 are integrated).

Illustrative examples of the N-type dopant contained in the N-type layer 12 and the N⁺ layer 18 include P (phosphorus), Sb (antimony), As (arsenic), and Bi (bismuth). Illustrative examples of the P-type dopant contained in the 40 P⁺ layer **19** include B (boron), Ga (gallium), Al (aluminum), and In (indium).

[Solar Cell Module]

Subsequently, the inventive solar cell module will be described. The inventive solar cell module is provided with 45 the foregoing inventive solar cell. Specifically, it can be formed by connecting a plurality of the arranged inventive solar cells in series by using an inter connector, for example. Various module structures can be applied without limiting thereto. In such a solar cell module, the light-induced 50 degradation and resistance loss are eliminated, and the conversion efficiency is excellent.

[Method for Manufacturing Solar Cell]

Then, the method for manufacturing the inventive solar cell will be described with reference to FIG. 5. FIG. 5 is a 55 process flow diagram showing an example of a method for manufacturing the inventive solar cell. The method described below is a typical example, and the method for manufacturing the inventive solar cell is not limited thereto. First, as shown in FIG. 5 (a), a gallium-dopes substrate with 60 a resistivity of 2.5 Ω ·cm or less is prepared for the P-type silicon substrate in which one main surface is a lightreceiving surface and another main surface is a backside.

It is preferable that the resistivity of the gallium-doped substrate prepared in the step (a) be $0.2 \Omega \cdot \text{cm}$ or more. When 65 using a gallium-doped substrate, since the segregation coefficient of gallium is relatively high, the resistivity of an ingot

grown by a CZ method differs by about six times at the top and at the tail. In order to manufacture a solar cell at low cost, it is desirable to use each of these ingots entirely one piece, and it is preferable that the difference of the resistivity of a substrate be considered in the design stage. By preparing a gallium-doped substrate with a resistivity of $0.2 \ \Omega \cdot cm$ or more in the step (a), it is possible to manufacture plural solar cells having a PERC structure or a PERL structure which can show similar current even when these solar cells differ the resistivity by about six times, and to reduce excess loss when these solar cells are modularized. This makes it possible to manufacture a solar cell module at lower cost. The method for measuring the resistivity of a gallium-doped substrate is not particularly limited, and includes a four-

The silicon single crystal from which the gallium-doped substrate is sliced can be produced by a CZ method, for example, as described above. In this case, gallium and a polycrystalline material may be introduced into a crucible in As shown in FIG. 1, the inventive solar cell 10 is 20 a lump to form a raw material melt. It is desirable to produce dopant by producing and pulverizing a silicon single crystal doped with higher concentration of gallium, and to adjust the concentration by introducing the dopant into melted polycrystalline silicon for CZ material so as to have a desired concentration, since it is necessary to precisely adjust the concentration, particularly in mass production. The gallium-doped substrate can be obtained by slicing thus obtained gallium-doped silicon single crystal.

> Subsequently, slice damages on the surface of the substrate can be removed by etching with a high-concentration alkaline solution such as sodium hydroxide and potassium hydroxide in a concentration of 5 to 60%, or mixed acid of hydrofluoric acid and nitric acid, etc. as shown in FIG. 5(b).

Then, the substrate surface can be processed to form electrodes 14 are connected with each other (i.e., a structure 35 micro-roughness called texture as shown in FIG. 5 (c). The texture is an effective method to reduce the reflectance of a solar cell. The texture can be produced by immersing the substrate in heated alkaline solution (concentration: 1 to 10%, temperature: 60 to 100° C.) such as sodium hydroxide, potassium hydroxide, potassium carbonate, sodium carbonate, and sodium hydrogenearbonate for about 10 minutes to 30 minutes. In many cases, a certain amount of 2-propanol (IPA: isopropyl alcohol) is added to the foregoing solution to promote the reaction.

After the damage-etching and texture formation, it is preferable to clean the substrate as shown in FIG. 5 (d). The cleaning can be performed by using an aqueous acid solution of hydrochloric acid, sulfuric acid, nitric acid, hydrofluoric acid, or mixed solvent thereof; or pure water, for example.

Subsequently, as shown in FIG. 5 (e), N-type layer is formed on the light-receiving surface of the gallium-doped substrate.

The method for forming an N-type layer in the step (e) is not particularly restricted. For example, it is possible to enumerate a method to thermally diffuse the dopant. This includes a vapor phase diffusion method in which POCl₃ (phosphoryl chloride) and the like introduced into a quartz tube furnace with carrier gas are diffused or a coating diffusion method in which a phosphorus-containing material and the like applied onto a substrate is diffused by thermal treatment. The coating method in the coating diffusion method includes spin-coating method, spray-coating method, ink-jet method, and screen printing method.

In the coating diffusion method, the N-type layer can be formed by coating the light-receiving surface with a material which contains N-type dopant followed by thermal treatment. For the material which contains N-type dopant, it is

possible to use a phosphorus diffusion source, which turns to glass by thermal treatment. This phosphorus diffusion source includes any known ones, and can be obtained by mixing P_2O_5 , pure water, polyvinyl alcohol (PVA), and tetraethyl orthosilicate (TEOS), for example.

For a method for manufacturing a solar cell having a PERL structure provided with an N⁺ layer on the light-receiving surface side and a P⁺ layer on the back surface side, it is possible to enumerate a method in which the light-receiving surface is locally coated with the N-type dopant-containing material, and the back surface is locally coated with P-type dopant-containing material, and then the substrate is subjected to a thermal treatment. In this case, it is possible to form diffusion masks on the light-receiving surface and/or the back surface in order to prevent autodoping and then to perform the thermal treatment in plural times.

For the P-type dopant-containing material, it is possible to use a boron diffusion source, which turns to glass by thermal 20 treatment. This boron diffusion source includes any known ones, and can be obtained by mixing B₂O₃, pure water, and PVA, for example.

Then, as shown in FIG. **5** (*f*), the PN junction is isolated by using a plasma etcher. In this process, samples are 25 stacked so as to prevent plasma and radical from getting into the light-receiving surface or the backside, and the side faces of the substrate are dry-etched by several microns under this stacked condition. This PN isolation by plasma etching may be performed before removing the boron glass and phosphorus glass or may be performed after the removal. It is also possible to form a trench with laser as an alternative method to the PN isolation.

After the step (e), not a little quantity of glass layer is formed on the surface of the substrate. The glass on the 35 surface is removed by hydrofluoric acid, etc., as shown in FIG. 5(g).

Subsequently, as shown in FIG. 5 (h), a surface passivation layer can be formed on the light-receiving surface of the gallium-doped substrate. For the light-receiving surface 40 passivation layer, it is possible to use the same ones described in the item of the solar cell.

Then, as shown in FIG. 5 (i), a surface passivation layer can be deposited on the back surface of the gallium-doped substrate. For the back surface passivation layer, it is possible to use the same ones described in the item of the solar cell.

Subsequently, as shown in FIG. **5** (*j*), the back surface passivation layer can be removed just on the contact area for a back surface electrode. The removal of the back surface 50 passivation layer can be performed by using a photolithography method or an etching paste, for example. This etching paste contains at least one selected from the group consisting of phosphoric acid, hydrofluoric acid, ammonium fluoride, and ammonium hydrogen fluoride as an etching 55 component together with water, organic solvent, and a viscosity agent, for example.

At this stage, it is possible to determine a pitch to remove the back surface passivation layer in the step (j) (which corresponds to an pitch of the contact areas) on the basis of 60 the relation represented by the formula (1) for the resistivity of the gallium-doped substrate prepared in the step (a). This makes it possible to certainly manufacture a solar cell that is excellent in conversion efficiency. It is also possible to precisely determine the upper and the lower limits of the 65 back surface electrode pitch P_{rm} [mm] and the resistivity R_{sub} [Ω ·cm] to fabricate the solar cell.

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Then, as shown in FIG. 5 (k), a paste for a back surface electrode is printed onto the backside of the gallium-doped substrate, followed by drying. For example, a paste in which Al powders are mixed with an organic binder is applied onto the backside of the substrate by screen printing. For a material of the back surface electrode, Ag and so on also can be used. The back surface electrode needs to be formed on the contact area at least. Alternatively, the back surface electrode may be formed and integrated to the whole back surface. In this case, the back surface electrode actually contacts the substrate locally.

Subsequently, as shown in FIG. 5 (*l*), a paste for a light-receiving surface electrode is printed onto the light-receiving surface of the gallium-doped substrate, followed by drying. For example, an Ag paste in which Ag powders and glass frit are mixed with an organic binder is applied onto the light-receiving surface of the substrate by screen printing. The step (k) and the step (l) may be performed in the opposite order.

After the foregoing printing of the electrodes, for the paste on a light-receiving surface electrode and the paste on a back surface electrode, firing is done as shown in FIG. 5 (*m*). In this way, the light-receiving surface electrode and the back surface electrode are formed by printing the pastes followed by firing. The firing is generally performed by thermal treatment at a temperature of 700 to 800° C. for 5 to 30 minutes. This thermal treatment makes the Ag powders penetrate to the passivation layer (fire through) on the light-receiving surface side to electrically conduct the light-receiving surface electrode and the gallium-doped substrate. It is also possible to bake back surface electrode and the light-receiving surface electrode separately.

In such a process, the solar cell shown in FIG. 1 and FIG. 3 can be manufactured. The inventive solar cell module can be obtained by modularizing the solar cells thus obtained.

It is to be noted that the present invention is not limited to the foregoing embodiment. The embodiment is just an exemplification, and any examples that have substantially the same feature and demonstrate the same functions and effects as those in the technical concept described in claims of the present invention are included in the technical scope of the present invention.

The invention claimed is:

1. A method for manufacturing a solar cell, the method comprising:

preparing a P-type silicon substrate in which one main surface is a light-receiving surface and the other main surface is a backside, wherein:

the P-type silicon substrate is a silicon single crystal substrate doped with gallium and is produced from an ingot grown by a Czochralski method, and

the P-type silicon substrate has a resistivity of 0.2 to 2.5 $\Omega \cdot cm$;

forming an N-type layer on at least a part of the light-receiving surface of the P-type silicon substrate;

forming a surface passivation layer on the backside of the P-type silicon substrate;

forming a first electrode on the light-receiving surface; forming a second electrode comprising a plurality of back surface electrodes onto the backside of the P-type silicon substrate such that:

the plurality of back surface electrodes penetrate through the surface passivation layer to contact the P-type silicon substrate in a plurality of contact areas, and

a pitch P_{rm} [mm] of the plurality of contact areas and the resistivity R_{sub} [$\Omega \cdot cm$] of the P-type silicon substrate satisfy the relation represented by the following formula (1)

$$\log(R_{sub}) \leq -\log(P_{rm}) + 1.0 \tag{1},$$

wherein:

the pitch of the plurality of contact areas is 0.1 mm or more and 10 mm or less, and

the total area of the plurality of contact areas of the back surface electrodes is about 5% or more and 20% or less on the basis of the whole of the backside; and

determining the pitch P_{rm} [mm] such that, with the proviso that the pitch P_{rm} [mm] is in the horizontal axis and the resistivity R_{sub} [$\Omega \cdot cm$] of the P-type silicon substrate is in the vertical axis, the short-circuit current density shows smaller variations as compared to the resistivity R_{sub} [$\Omega \cdot cm$] and is more than 37 mA/cm² and less than about 40 mA/cm², but within a value defined by the lines of 0.2 Ω ·cm and 2.5 Ω ·cm of the resistivity of the P-type silicon substrate and the line of $\log (R_{sub}) = -\log(P_{rm}) + 1.0$, wherein:

the solar cell shows a similar current throughout the range of 0.2 to 2.5 Ω ·cm of the resistivity of the P-type silicon substrate, and

a conversion efficiency of the solar cell is about 20%.

- 2. The method according to claim 1, wherein each of the contact areas has a higher P-type dopant concentration than $_{30}$ other areas of the backside of the P-type silicon substrate.
- 3. A method for manufacturing a solar cell module, the method comprising:

manufacturing a plurality of solar cells according to the method of claim 1; and

connecting the plurality of solar cells in series by using an inter connector.

4. A method for manufacturing a solar cell, the method comprising:

surface is a light-receiving surface and the other main surface is a backside, wherein:

the P-type silicon substrate is a silicon single crystal substrate doped with gallium and is produced from an ingot grown by a Czochralski method, and

the P-type silicon substrate has a resistivity of 0.2 to 2.5 Ω ·cm;

forming an N-type layer on at least a part of the lightreceiving surface of the P-type silicon substrate;

forming a first electrode on the light-receiving surface; forming a surface passivation layer on the backside of the P-type silicon substrate;

determining a pitch P_{rm} [mm] of contact areas to be formed between a plurality of back surface electrodes and the P-type silicon substrate such that:

the pitch P_{rm} [mm] and the resistivity R_{sub} [$\Omega \cdot cm$] of the P-type silicon substrate satisfy the relation represented by the following formula (1)

$$\log(R_{sub}) \leq -\log(P_{rm}) + 1.0 \tag{1), and}$$

with the proviso that the pitch P_{rm} , [mm] is in the horizontal axis and the resistivity R_{sub} [$\Omega \cdot cm$] of the P-type silicon substrate is in the vertical axis, the short-circuit current density shows smaller variations as compared to the resistivity R_{sub} [$\Omega \cdot cm$] and is 65 more than 37 mA/cm² and less than about 40 mA/cm², but within a value defined by the lines of

0.2 Ω ·cm and 2.5 Ω ·cm of the resistivity of the P-type silicon substrate and the line of $log(R_{sub})= \log(P_{rm})+1.0$; and

forming a second electrode comprising the plurality of back surface electrodes on the backside of the P-type silicon substrate so that the plurality of back surface electrodes penetrate through the surface passivation layer to contact the P-type silicon substrate at the contact areas that satisfy the determined pitch P_{rm} [mm],

wherein:

the pitch of the contact areas is 0.1 mm or more and 10 mm or less,

the total area of the contact areas is about 5% or more and 20% or less on the basis of the whole of the backside, the solar cell shows a similar current throughout the range of 0.2 to 2.5 Ω ·cm of the resistivity of the P-type silicon

substrate, and a conversion efficiency of the solar cell is about 20%.

- **5**. The method according to claim **4**, further comprising: removing only parts of the surface passivation layer corresponding to the contact areas.
- **6**. The method according to claim **1**, wherein each of the back surface electrodes has a width of 15 to 100 μm.
- 7. The method according to claim 4, wherein each of the back surface electrodes has a width of 15 to 100 μm.
- **8**. The method according to claim **1**, wherein the solar cell has a PERC or PERL structure.
- 9. The method according to claim 4, wherein the solar cell has a PERC or PERL structure.
- 10. The method according to claim 3, wherein the plurality of solar cells vary in resistance.
- 11. A method for manufacturing a solar cell comprising: 35 (i) a P-type silicon substrate in which one main surface is a light-receiving surface and the other main surface is a backside, (ii) a backside electrode comprising a plurality of back surface electrodes in contact with the P-type silicon substrate in a plurality of contact areas, wherein the plurality preparing a P-type silicon substrate in which one main $_{40}$ of contact areas has a pitch P_{rm} [mm] of 0.1 to 10 mm, (iii) an N-type layer formed on at least a part of the lightreceiving surface of the P-type silicon substrate, (iv) a back surface passivation layer provided on the whole of backside of the P-type silicon substrate, (v) a light-receiving surface 45 passivation layer, and (vi) a light-receiving surface electrode that is in electrical contact with the N-type layer,

the method comprising:

preparing, as the P-type silicon substrate, a silicon single crystal substrate doped with gallium, the silicon substrate being produced from an ingot grown by a Czochralski method and having the resistivity of 0.2 to $2.5 \Omega \cdot cm$

determining a value of the pitch P_{rm} [mm] of the plurality of contact areas such that, with the proviso that the pitch P_{rm} [mm] is in the horizontal axis and the resistivity R_{sub} [Ω ·cm] of the P-type silicon substrate is in the vertical axis, the short-circuit current density shows smaller variations as compared to the resistivity R_{sub} $[\Omega \cdot cm]$ and is more than 37 mA/cm² and less than about 40 mA/cm², but within a value defined by the lines of $0.2 \ \Omega \cdot cm$ and $2.5 \ \Omega \cdot cm$ of the resistivity of the P-type silicon substrate and the line of $log(R_{sub})=-log$ $(P_{rm})+1.0$, and

determining whether the pitch P_{rm} [mm] of the plurality of contact areas and the resistivity R_{sub} [$\Omega \cdot cm$] of the P-type silicon substrate satisfy the relationship represented by the following formula (1)

(1),

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 $\log(R_{sub}) \leq -\log(P_{rm}) + 1.0$

wherein:

the plurality of back surface electrodes penetrate through the back surface passivation layer so as to be in contact with the P-type silicon substrate in the plurality of contact areas and the total area of the plurality of contact areas is about 5% or more and 20% or less on the basis of the whole of the backside,

the solar cell shows a similar current throughout the range of 0.2 to 2.5 Ω ·cm of the resistivity of the P-type silicon substrate, and

a conversion efficiency of the solar cell is about 20%.

12. The method according to claim 1, wherein with the proviso that the pitch P_{rm} [mm] is in the horizontal axis and the resistivity R_{sub} [Ω ·cm] of the P-type silicon substrate is in the vertical axis:

the short-circuit current density is about 38 mA/cm^2 when the pitch is 1 mm and the resistivity is $0.2 \Omega \cdot \text{cm}$, and the short-circuit current density is about 39 mA/cm^2 when the pitch is 1 mm and the resistivity is $2.5 \Omega \cdot \text{cm}$.

13. The method according to claim 3, wherein with the proviso that the pitch P_{rm} [mm] is in the horizontal axis and the resistivity R_{sub} [$\Omega \cdot \text{cm}$] of the P-type silicon substrate is in the vertical axis:

the short-circuit current density is about $38 \text{ mA/cm}^2 \text{ when}$ the pitch is 1 mm and the resistivity is $0.2 \Omega \cdot \text{cm}$, and the short-circuit current density is about $39 \text{ mA/cm}^2 \text{ when}$ the pitch is 1 mm and the resistivity is $2.5 \Omega \cdot \text{cm}$.

14. The method according to claim 8, wherein with the proviso that the pitch P_{rm} [mm] is in the horizontal axis and the resistivity R_{sub} [Ω ·cm] of the P-type silicon substrate is in the vertical axis:

the short-circuit current density is about 38 mA/cm^2 when the pitch is 1 mm and the resistivity is $0.2 \Omega \cdot \text{cm}$, and the short-circuit current density is about 39 mA/cm^2 when 35 the pitch is 1 mm and the resistivity is $2.5 \Omega \cdot \text{cm}$.

- 15. The method according to claim 4, wherein each of the contact areas has a higher P-type dopant concentration than other areas of the backside of the P-type silicon substrate.
- 16. The method according to claim 11, wherein each of the contact areas has a higher P-type dopant concentration than other areas of the backside of the P-type silicon substrate.
- 17. The method according to claim 1, wherein the short-circuit current density is more than 39 mA/cm² and less than about 40 mA/cm², and the pitch of the plurality of contact areas is 1 mm or more and 10 mm or less.
- 18. The method according to claim 4, wherein the short-circuit current density is more than 39 mA/cm² and less than about 40 mA/cm², and the pitch of the contact areas is 1 mm or more and 10 mm or less.
- 19. The method according to claim 11, wherein the short-circuit current density is more than 39 mA/cm² and

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less than about 40 mA/cm², and the pitch of the plurality of contact areas is 1 mm or more and 10 mm or less.

20. A method for manufacturing a solar cell, the method comprising:

preparing a P-type silicon substrate in which one main surface is a light-receiving surface and the other main surface is a backside, wherein:

the P-type silicon substrate is a silicon single crystal substrate doped with gallium and is produced from an ingot grown by a Czochralski method, and the P-type silicon substrate has a resistivity in a range of 0.2 to $2.5 \Omega \cdot cm$;

forming an N-type layer on at least a part of the light-receiving surface of the P-type silicon substrate;

forming a surface passivation layer on the backside of the P-type silicon substrate;

forming a first electrode on the light-receiving surface; forming a second electrode comprising a plurality of back surface electrodes onto the backside of the P-type silicon substrate such that:

the plurality of back surface electrodes penetrate through the surface passivation layer to contact the P-type silicon substrate in a plurality of contact areas which are provided in a plurality of regular patterns with a regular pitch; and

determining the regular pitch such that, with the proviso that the pitch Prm [mm] is in the horizontal axis and the resistivity Rsub [Ω ·cm] of the P-type silicon substrate is in the vertical axis, the short-circuit current density of the solar cell shows a smaller variation as compared to the resistivity of the P-type silicon substrate and is more than 37 mA/cm2 and less than about 40 mA/cm2, but within a value defined by the lines of 0.2 Ω ·cm and 2.5 Ω ·cm of the resistivity of the P-type silicon substrate and the line of log (R sub)=-log(Prm)+1.0,

wherein:

the solar cell has a similar current throughout the range of the resistivity of 0.2 to 2.5 Ω ·cm of the P-type silicon substrate,

the total area of the plurality of contact areas of the back surface electrodes is 5% or more and 20% or lesson the basis of the whole of the backside, and

a conversion efficiency of the solar cell is about 20%.

- 21. A method for manufacturing a solar cell module comprising manufacturing a plurality of solar cells according to the method of claim 20, wherein the plurality of solar cells vary in resistance and are connected in series.
- 22. The method according to claim 21, further comprising:

connecting the plurality of solar cells in series by using an inter connecter.

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